ZXMP3F37N8 30V SO8 P-channel enhancement mode MOSFET

Summary

V _{(BR)DSS} (V)	R _{DS(on)} (Ω)	I _D (A)
-30	0.025 @ V _{GS} =-10V	-10.7
	0.041 @ V _{GS} =-4.5V	



Description

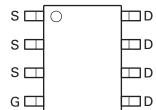
This new generation Trench MOSFET from Zetex has been designed to minimize the on-state resistance ($R_{DS(on)}$) and yet maintain superior switching performance making it ideal for high efficiency power management applications.

Features

- Low on-resistance
- · Fast switching speed
- Low gate drive
- SO8 package

Applications

- · DC-DC Converters
- · Power management functions
- Disconnect switches
- Motor control



Ordering information

Device	Reel size (inches)	Tape width (mm)	•	
ZXMP3F37N8TA	7	12	500	

Device marking

ZXMP 3F37

Absolute maximum ratings

Parameter	Symbol	Limit	Unit
Drain-Source voltage	V_{DSS}	-30	V
Gate-Source voltage	V_{GS}	±20	V
Continuous Drain current @ V _{GS} = -10V; T _A =25°C (b)	I _D	-8.5	V
@ V _{GS} = -10V; T _A =70°C (b)		-6.8	
@ V_{GS} = -10V; T_A =25°C (a)		-6.4	
@ V_{GS} = -10V; T_L =25°C (d)		-10.7	
Pulsed Drain current (c)	I _{DM}	-39.5	Α
Continuous Source current (Body diode) (b)	I _S	-4.4	Α
Pulsed Source current (Body diode) (C)	I _{SM}	-39.5	Α
Power dissipation at T _A =25°C ^(a)	P _D	1.56	W
Linear derating factor		12.5	mW/°C
Power dissipation at T _A =25°C ^(b)	PD	2.8	W
Linear derating factor		22.2	mW/°C
Power dissipation at T _L =25°C (d)	P _D	4.4	W
Linear derating factor		35.4	mW/°C
Operating and storage temperature range	T _j , T _{stg}	-55 to 150	°C

Thermal resistance

Parameter	Symbol	Value	Unit	
Junction to ambient ^(a)	$R_{ heta JA}$	80	°C/W	
Junction to ambient ^(b)	$R_{\theta JA}$	45	°C/W	
Junction to lead ^(d)	$R_{ heta JL}$	28.26	°C/W	

NOTES:

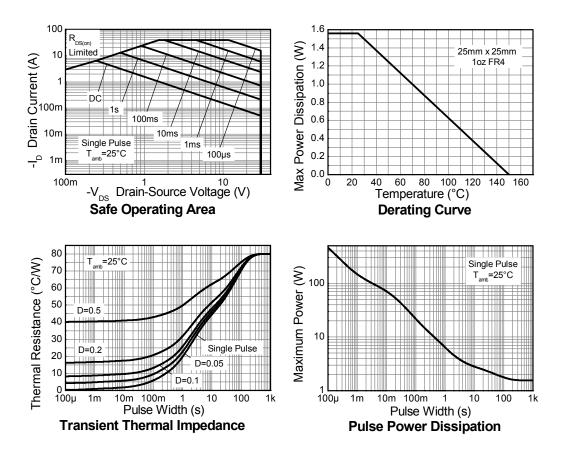
⁽a) For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

⁽b) Mounted on FR4 PCB measured at $t \le 10$ sec.

⁽c) Repetitive rating on 25mm x 25mm FR4 PCB, D=0.02, pulse width 300us – pulse width limited by maximum junction temperature.

⁽d) Thermal resistance from junction to solder-point (at the end of the drain lead).

Thermal characteristics

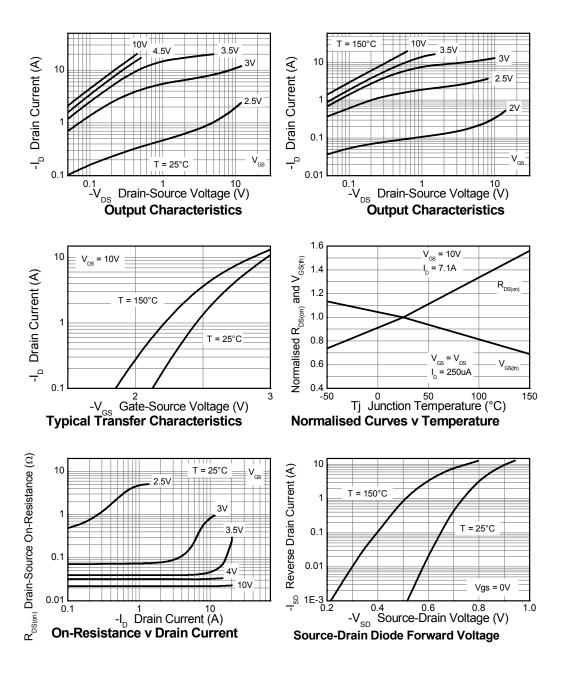


Electrical characteristics (at T_{amb} = 25°C unless otherwise stated)

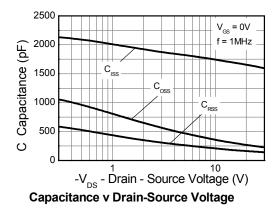
Parameter	Symbol	Min.	Тур.	Max.	Unit	Conditions
Static						
Drain-Source breakdown voltage	V _{(BR)DSS}	-30			V	$I_D = -250 \mu A, V_{GS} = 0 V$
Zero Gate voltage Drain current	I _{DSS}			-1.0	μA	V _{DS} =-30V, V _{GS} =0V
Gate-Body leakage	I_{GSS}			100	nA	V_{GS} =±20V, V_{DS} =0V
Gate-Source threshold voltage	V _{GS(th)}	-1.3		-2.5	V	I_D = -250 μ A, V_{DS} = V_{GS}
Static Drain-Source on-state resistance (*)	R _{DS(on)}			0.025 0.041	Ω	V_{GS} = -10V, I_{D} = -7.1A V_{GS} = -4.5V, I_{D} = -5.5A
Forward Transconductance (*)(†)	9 _{fs}		18.6		S	V _{DS} = -15V, I _D = -7.1A
Dynamic ^(†)					•	
Input capacitance	C _{iss}		1678		pF	
Output capacitance	C _{oss}		303		pF	V _{DS} = -15V, V _{GS} =0V
Reverse transfer capacitance	C _{rss}		178		pF	f=1MHz
Switching (‡)(†)			_			
Turn-on-delay time	t _{d(on)}		3.5		ns	
Rise time	t _r		4.9		ns	V _{DD} = -15V, V _{GS} = -10V
Turn-off delay time	t _{d(off)}		44		ns	I _D = -1A
Fall time	t _f		28		ns	$R_G \cong 6.0\Omega$,
Gate charge						
Total Gate charge	Qg		31.6		nC	
Gate-Source charge	Q _{gs}		4.3		nC	V _{DS} = -15V, V _{GS} = -10V
Gate-Drain charge	Q _{gd}	_	6.2		nC	I _D = -7.1A
Source-Drain diode						
Diode forward voltage (*)	V _{SD}		-0.80	-1.2	V	I _S = -1.7A,V _{GS} =0V
Reverse recovery time (‡)	t _{rr}		16.2		ns	I _S = -2.2A,di/dt=100A/μs
Reverse recovery charge ^(‡)	Q _{rr}		10		nC	71S2.2A,ui/αι-100A/μS

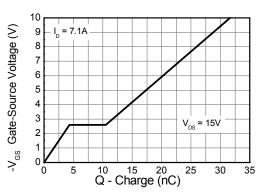
^(*) Measured under pulsed conditions. Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$. (†)Switching characteristics are independent of operating junction temperature. (‡)For design aid only, not subject to production testing

Typical characteristics



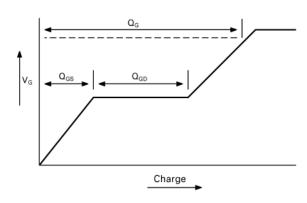
Typical characteristics

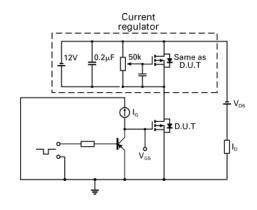




Gate-Source Voltage v Gate Charge

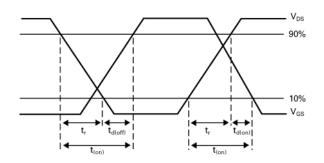
Test circuits

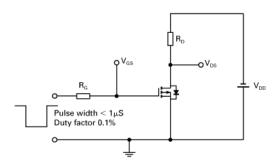




Basic gate charge waveform

Gate charge test circuit

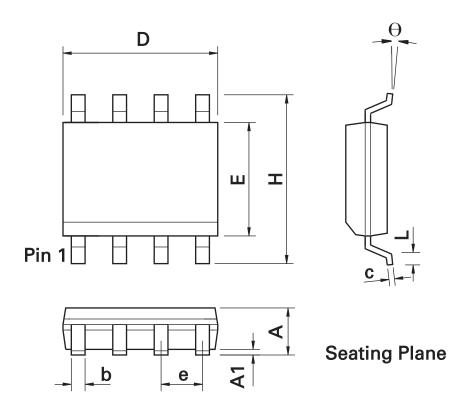




Switching time waveforms

Switching time test circuit

Package outline SO8



SO8 Package Information

DIM	Inc	hes	Millim	neters	DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
Α	0.053	0.069	1.35	1.75	е	0.050 BSC		1.27 BSC	
A1	0.004	0.010	0.10	0.25	b	0.013	0.020	0.33	0.51
D	0.189	0.197	4.80	5.00	С	0.008	0.010	0.19	0.25
Н	0.228	0.244	5.80	6.20	U	0°	8°	0°	8°
Е	0.150	0.157	3.80	4.00	h	0.010	0.020	0.25	0.50
L	0.016	0.050	0.40	1.27	-	-	-	-	1

Note: Controlling dimensions are in inches. Approximate dimensions are provided in millimeters

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